

# AUTOMOTIVE CURRENT TRANSDUCERS OPEN LOOP TECHNOLOGY HSNBV 800-R01





#### Introduction

The HSNBV series is for the electronic measurement of DC, AC or pulsed currents in high power and low voltage automotive applications with galvanic separation between the primary circuit (high power) and the secondary circuit (electronic circuit). The HSNBV series gives you the choice of having different current measuring ranges in the same housing.

#### **Features**

- Ratiometric transducer
- · Open Loop transducer using the Hall effect
- Low voltage application
- Unipolar +5 V DC power supply
- Maximum RMS primary admissible current: defined by busbar to have T < +150 °C</li>
- Operating temperature range: -40 °C < T < 125 °C
- Output voltage: full ratio-metric (in sensitivity and offset).

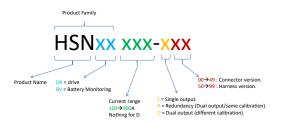
# **Special feature**

Special busbar shape.

# **Advantages**

- Excellent accuracy
- Very good linearity
- Very low thermal offset drift
- · Very low thermal sensitivity drift
- Galvanic separation
- Non intrusive solution.

# Part numbering



# **Automotive application**

- Battery Management
- EV, Hybrid and utility vehicles
- 48 V battery.

# **Principle of HSNBV Family**

The open loop transducers uses a Hall effect integrated circuit. The magnetic flux density B, contributing to the rise of the Hall voltage, is generated by the primary current  $I_{\rm p}$  to be measured. The current to be measured  $I_{\rm p}$  is supplied by a current source i.e. battery or generator (Figure 1). Within the linear region of the hysteresis cycle, B is proportional to:

$$B(I_p) = a \times I_p$$

The Hall voltage is thus expressed by:

$$U_{\mathsf{Hall}} = (c_{\mathsf{Hall}} / d) \times I_{\mathsf{Hall}} \times a \times I_{\mathsf{P}}$$

Except for  $I_{\rm p}$ , all terms of this equation are constant. Therefore:

 $\begin{array}{lll} U_{\rm Hall} = b \times I_{\rm p} \\ a & {\rm constant} \\ b & {\rm constant} \\ c_{\rm Hall} & {\rm Hall \ coefficient} \\ d & {\rm thickness \ of \ the \ Hall \ plate} \\ I_{\rm Hall} & {\rm current \ across \ the \ Hall \ plates} \end{array}$ 

The measurement signal  $U_{\rm Hall}$  amplified to supply the user output voltage or current.

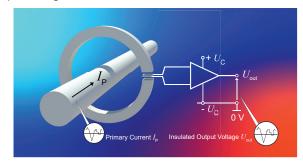


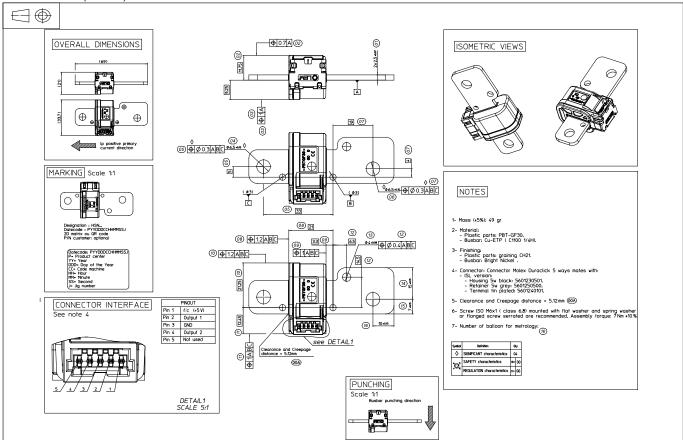
Fig. 1: Principle of the open loop transducer

N° 97.O3.56.R01.0





## **Dimensions** (in mm)



#### **Mechanical characteristics**

Plastic case
 Magnetic core
 Busbar
 Mass
 Pins
 PBT GF 30
 FeSi alloy
 Copper
 49 g ± 5 %
 Prass tin plated

• IP level IP × 2

# **Mounting recommendation**

• Mating connector: Molex duraclik 5 pin:

ISL version

Housing 5 pin black: 5601230501Retainer 5 pin grey: 5601250500Teminal tin plated: 5601240101

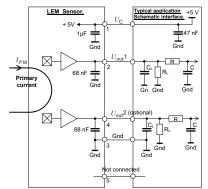
• Assembly torque: see notes on drawing.

Screw mounted with flat washer and spring washer or flanged screw serrated are recommended.

#### Remark

•  $U_{\text{out}} > U_{\text{O}}$  when  $I_{\text{P}}$  flows in the positive direction (see arrow on drawing).

#### **Electronic schematic**



 $C_{\rm L}$  < 100 nF EMC protection (optional) RC Low pass filter (optional)

## On board diagnostic

 $R_{\rm L}$  > 10 K $\Omega$ . Resistor for signal line diagnostic (optional)

$U_{out}$	Diagnostic
Open circuit	<i>U</i> <sub>IN</sub> ≤ 0.15 V
Short GND	<i>U</i> <sub>IN</sub> ≤ 0.15 V



# Absolute ratings (not operating)

# **HSNBV 800-R01**

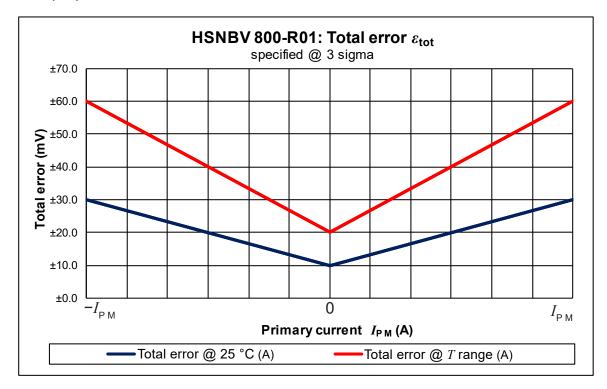
Parameter	Symbol	Unit	Specification			Conditions
Parameter			Min	Typical	Max	Conditions
Maximum supply voltage	$U_{c}$	V	-14		14	
Insulation resistance	$R_{INS}$	ΜΩ	500			500 V DC, ISO 16750-2
Maximum output voltage	$U_{\mathrm{out}}$	V	-14		14	$U_{ m out}$ Reverse / Forward voltage
Maximum output current	$I_{\mathrm{out}}$	mA	-10		10	Continuous
Ambient storage temperature	$T_{Ast}$	°C	-40		125	
Electrostatic discharge voltage (HBM)	$U_{\rm ESDHBM}$	kV			8	IEC 61000-4-2 / ISO 10605
Maximum admissible vibration (random RMS)	γ	m·s <sup>-2</sup>				see profile on page 7/8
RMS voltage for AC insulation test	$U_{d}$	kV			2.5	50 Hz, 1 min; IEC 60664 part1
Creepage distance	$d_{Cp}$	mm		5.12		
Clearance	$d_{\text{CI}}$	mm		5.12		
Comparative tracking index	CTI			PLC0		≥ 600 V

# Operating common characteristics in nominal range $(I_{_{\rm P\,N}})$

Supply voltage Ambient operating temperature	$\frac{U_{\rm C}}{T_{\rm A}}$	Unit Electrica		Typical	Max	Conditions					
117			al Data								
11.7		\/		Electrical Data							
Ambient operating temperature	T	v	4.75	5	5.25						
F	1 A	°C	-40		125						
Output voltage	$U_{\mathrm{out}}$	V	$U_{\text{out}} = (U_{\text{C}}/5) \times (U_{\text{o}} + S \times I_{\text{P}})$		$S + S \times I_{P}$						
Electrical Data											
Primary current, measuring range (output 1)	<i>I</i> <sub>PM</sub> 1	Α	-800		800						
Sensitivity (output 1)	S 1	mV/A		2.5		@ $T_A = 25  ^{\circ}\text{C}$					
Offset voltage (output 1)	$U_{o} 1$	V		2.5		$\textcircled{0}$ $U_{\text{C}}$ = 5 V DC					
Primary current, measuring range (output 2)	$I_{PM}2$	Α	-800		800						
Sensitivity (output 2)	S 2	mV/A		2.5		@ $T_A = 25  ^{\circ}\text{C}$					
Offset voltage (output 2)	$U_{o}$ 2	V		2.5		@ $U_{\rm C}$ = 5 V DC					
Output resolution		mV		1.25							
Output clamping high voltage	$U_{\mathrm{SZ}}$	V	4.70	4.75	4.80	@ $U_{\rm C}$ = 5 V, @ -40 °C < $T$ < 125 °C					
Output clamping low voltage	$U_{\mathrm{SZ}}$	V	0.20	0.25	0.30	@ $U_{\rm C}$ = 5 V, @ -40 °C < $T$ < 125 °C					
Comment compounding	7	A		15		@ $T_{\rm A}$ = 25 °C, @ $U_{\rm C}$ = 5 V					
Current consumption	$I_{\text{C}}$	mA			20						
Load resistance	$R_{L}$	kΩ	10								
Output internal resistance	$R_{\rm out}$	Ω		1	10	@ $T_A = 25  ^{\circ}\text{C}$					
	P	Performa	nce Data								
Ratiometricity error	$\varepsilon_{_{_{ m r}}}$	%		±0.3		@ T <sub>A</sub> = 25 °C					
Sensitivity error	$\epsilon_{_S}$	%		±1		$\textcircled{0}$ $T_{\text{A}}$ = 25 °C, $\textcircled{0}$ $U_{\text{C}}$ = 5 V					
Electrical offset voltage	$U_{\mathrm{O}\mathrm{E}}$	mV		±4.0		@ $T_{\rm A}$ = 25 °C, @ $U_{\rm C}$ = 5 V					
Magnetic offset voltage	$U_{OM}$	mV		±2		@ $U_{\rm C}$ = 5 V, @ $T_{\rm A}$ = 25 °C					
Linearity error	$\varepsilon_{L}$	%		±0.5		% of full scale, method 2					
Average temperature coefficient of $U_{\text{OE}}$	$TCU_{ extsf{OEAV}}$	mV/°K	-0.1	±0.04	0.1	@ U <sub>c</sub> = 5 V					
Average temperature coefficient of S	$TCS_{AV}$	%/°K	-0.03	±0.01	0.03						
Delay time to 70 % of the final output value for $I_{\rm PN}$ step	t <sub>D 70</sub>	ms			10						
Frequency bandwidth	BW	Hz		1100		@ -3 dB					
Peak-to-peak noise voltage	$U_{\rm no\;pp}$	mV			10	DC to 1 MHz					
RMS noise voltage	$U_{no}$	mV			1.5	DC to 1 MHz					
Start up time	t <sub>start</sub>	ms			1						
Settling time	t <sub>s</sub>	ms			10						



# Total error (mV)



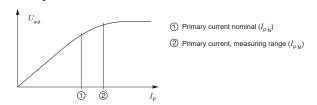
<i>I</i> <sub>P</sub> (A)	25 °C initial	T°C range initial	25 °C after reliability	T°C after reliability
-I <sub>PM</sub>	±30 mV	±60 mV	±53 mV	±60 mV
0	±10 mV	±20 mV	±10 mV	±20 mV
$I_{PM}$	±30 mV	±60 mV	±53 mV	±60 mV





#### PERFORMANCES PARAMETERS DEFINITIONS

## **Primary current definition:**



# Definition of typical, minimum and maximum values:

Minimum and maximum values for specified limiting and safety conditions have to be understood as such as values shown in "typical" graphs. On the other hand, measured values are part of a statistical distribution that can be specified by an interval with upper and lower limits and a probability for measured values to lie within this interval. Unless otherwise stated (e.g. "100 % tested"), the LEM definition for such intervals designated with "min" and "max" is that the probability for values of samples to lie in this interval is 99.73 %. For a normal (Gaussian) distribution, this corresponds to an interval between -3 sigma and +3 sigma. If "typical" values are not obviously mean or average values, those values are defined to delimit intervals with a probability of 68.27 %, corresponding to an interval between -sigma and +sigma for a normal distribution. Typical, minimum and maximum values are determined during the initial characterization of a product.

#### **Output noise voltage:**

The output voltage noise is the result of the noise floor of the Hall elements and the linear amplifier.

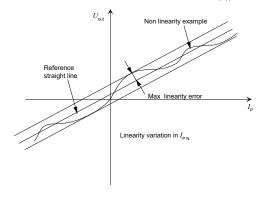
#### **Magnetic offset:**

The magnetic offset is the consequence of an any current on the primary side. It's defined after a stated excursion of primary current.

#### Linearity:

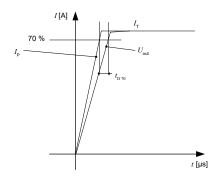
The maximum positive or negative discrepancy with a reference straight line  $U_{\rm out}$  =  $f(I_{\rm P})$ .

Unit: linearity (%) expressed with full scale of  $I_{PN}$ .



# Delay time $t_{D70}$ :

The time between the primary current signal  $(I_{\rm P\ N})$  and the output signal reach at 70 % of its final value.



#### Sensitivity:

The transducer's sensitivity S is the slope of the straight line  $U_{\text{out}} = f(I_{\text{p}})$ , it must establish the relation:

$$U_{\text{out}}(I_{\text{P}}) = U_{\text{C}}/5 (S \times I_{\text{P}} + U_{\text{O}})$$

#### Offset with temperature:

The error of the offset in the operating temperature is the variation of the offset in the temperature considered with the initial offset at 25  $^{\circ}$ C.

The offset variation  $I_{\text{O }T}$  is a maximum variation the offset in the temperature range:

$$I_{\text{O}T} = I_{\text{O}E} \max - I_{\text{O}E} \min$$

The offset drift  $TCI_{\text{OEAV}}$  is the  $I_{\text{OT}}$  value divided by the temperature range.

# Sensitivity with temperature:

The error of the sensitivity in the operating temperature is the relative variation of sensitivity with the temperature considered with the initial offset at 25  $^{\circ}$ C.

The sensitivity variation  $S_{\tau}$  is the maximum variation (in ppm or %) of the sensitivity in the temperature range:  $S_{\tau}$  = (Sensitivity max – Sensitivity min) / Sensitivity at 25 °C. The sensitivity drift  $TCS_{\text{AV}}$  is the  $S_{\tau}$  value divided by the temperature range. Deeper and detailed info available is our LEM technical sales offices (www.lem.com).

# Offset voltage @ $I_p = 0$ A:

The offset voltage is the output voltage when the primary current is zero. The ideal value of  $U_{\rm O}$  is  $U_{\rm C}/$  2. So, the difference of  $U_{\rm O}-U_{\rm C}/$  2 is called the total offset voltage error. This offset error can be attributed to the electrical offset (due to the resolution of the ASIC quiescent voltage trimming), the magnetic offset, the thermal drift and the thermal hysteresis. Deeper and detailed info available is our LEM technical sales offices (www.lem. com).

## **Environmental test specifications:**

Refer to LEM GROUP test plan laboratory CO.11.11.515.0 with "Tracking Test Plan Auto" sheet.





# **Environmental test specifications:**

Refer to LEM GROUP test plan laboratory CO.11.11.515.0 with "Tracking\_Test Plan\_Auto" sheet.

Name	Standard	Conditions		
	ELECTRICAL TESTS			
RMS voltage for AC insulation test	IEC 60664 part 1	2.5 kV AC / 1 min / 50 Hz (I < 0.1 mA)		
Insulation resistance test	ISO 16750-2 (2010)	500 V DC, time = 60 s $R_{\rm INS} \ge$ 500 MΩ Minimum		
	ENVIRONMENTAL TESTS			
High <i>T</i> °C, High Humidity, Electrical connection	JESD 22-A101 (03/2009)	1000 h +85 °C / 85 % $RH$ $U_{\rm C}$ = 5 V DC, $I_{\rm P}$ = 0 A		
Thermal Cycle Test (Simplified profile)	IEC 60068-2-14, Test Nb	$T \min -40 ^{\circ}\text{C}$ , $T \max = +125 ^{\circ}\text{C}$ 1 cycle = 480 min, 30 cycles $U_{\text{C}} = 5 \text{V}$ ( $\equiv$ connected); $I_{\text{p}} = 0 \text{A}$		
Thermal Shock	ISO-16750-4 § 5.3.2 (04/2010)	1000 cycles 30 min "-40 °C" // 30 min " +85 °C" $U_{\rm C}$ not connected, $I_{\rm p}$ = 0 A		
High T °C Storage	IEC 60068-2-2, Bd (07/2007)	125 °C for 1000 h $U_{\rm C}$ not connected, $I_{\rm P}$ = 0 A		
Low T °C Storage	IEC 60068-2-1, Ad (03/2007)	$-40$ °C for 240 h $U_{\rm C}$ not connected, $I_{\rm P}$ = 0 A		
Mechanical Shock	ISO-16750-3 § 4.2.2 (12/2012)	50 g / 6 ms Half Sine @ 25 °C 10 shocks of each direction $U_{\rm C}$ not connected, $I_{\rm P}$ = 0 A		
Random vibration test in $T$ °C profile	IEC 60068-2-64	8 h for each axe; $I_{\rm p}$ = 0 A, without monitoring ISO 16750-3, 4.1.2.4, 3 g		
Powered Vibration Endurance CETP:00.00-E-412 § 5.11		Expose the Current Sensor to vibration log sweep at 20 °C while 5 V powered for 6 hours on each primary axis.  Vibration class II  Output voltage of all DUTs has been monitored		
	EMC TESTS ES96200 (11.2011)			
Radiated Emission Absorber Lined Shielded Enclosure (ALSE)	CISPR25 (2008) Table9 - class 5	f = 150 kHz to 2.5 GHz Criteria A acceptance @ 5 % of 2 V		
Radiated Immunity Bulk Current Injection (BCI)	GMW3097 § 3.4.1 (2015)	Level: GMW 3097 (2015) § 3.4.1 Table 13 - Level 1 (100 mA) (ISO11452-4 (2011) Annex E Table E1 Level 2) f = 1 MHz to 400 MHz .  Criteria A acceptance @ 5 % of 2 V		
Radiated Immunity Anechoic chamber	GMW3097 § 3.4.2 (2015)	Level: GMW 3097 (2015) § 3.4.2 Table 14 - Level 2 (100 V/m)  f = 400 MHz to 1 GHz; Level = 100 V/m (CW, AM 80 %)  f = 0.8 GHz to 2 GHz; Level = 70 V/m (CW, PM PRR = 217 Hz, PD = 0.57 ms)  f = 1 GHz to 2 GHz; Level = 70 V/m (CW)  Criteria A acceptance @ 5 % of 2 V		
ESD Test	GMW3097 § 3.6.3 (2015)	Level: GMW3097 (2015) § 3.6.3.3 Table 28 Contact discharges: $\pm 4$ , 6 kV; Air discharges: $\pm 8$ kV $U_{\rm C}$ = NO power supply (unconnected). Criteria B		





#### Recommendations for use:

#### Storage:

The LEM transducers must be stored in a dry location, within the following ambient room conditions (< 40 °C and < 60 % *RH*). The product should be stored in its original packing. Ensure during storage and transport, the units are not damaged by applying excess weight to the packaging. The transducers must not be stored more than 3 months. Maximal stackup storage of secondary container (pallet) must not exceed 2.

#### Unpacking:

When unpacking, care must be taken with cutting tools not to damage the transducer.

#### Handling:

The LEM transducers must be handled with care and not undergo any shocks or falls (fall = scrap). It is recommended to handle the transducer as long as possible inside its original packing (thermoform tray on customer's assembly station). It is forbidden to handle the transducers by their terminals. To avoid problems of ESD, it is recommended not to touch secondary terminals. Any rework operation are forbidden and will conduct part out of LEM warranty.

#### Installation:

The workshop and the people in contact with the transducers must be ESD protected. Before installing, be sure to check that the transducer corresponds to the required application. Be sure that the air gap between the housing of the transducer and the primary bar is suffisant to avoid damage in case of vibrations.

LEM does not recommand customers to make any maintenance on LEM sensors other wise, it will drive sensors directly out of warranty.

Concerning installation and re-installation, cauthougly care need to be taken for taped sensors same for screwed sensors.

Sensors fixed by clips must be scraped after any dismounting from the original locations.